

## Insulated Gate Bipolar Transistor (Trench IGBT), 175 A



**SOT-227**

| PRODUCT SUMMARY                      |                               |
|--------------------------------------|-------------------------------|
| $V_{CES}$                            | 1200 V                        |
| $I_{C(DC)}$                          | 175 A at 90 °C <sup>(1)</sup> |
| $V_{CE(on)}$ typical at 100 A, 25 °C | 1.73 V                        |
| $I_{F(DC)}$                          | 32 A at 90 °C                 |
| Speed                                | 8 kHz to 30 kHz               |
| Package                              | SOT-227                       |
| Circuit                              | Single switch diode           |

**Note**

<sup>(1)</sup> Maximum collector current admitted is 100 A, to not exceed the maximum temperature of terminals

**FEATURES**

- Trench IGBT technology with positive temperature coefficient
- Square RBSOA
- 10  $\mu$ s short circuit capability
- HEXFRED® antiparallel diodes with ultrasoft reverse recovery
- $T_J$  maximum = 150 °C
- Fully isolated package
- Very low internal inductance ( $\leq 5$  nH typical)
- Industry standard outline
- UL approved file E78996 
- Material categorization: for definitions of compliance please see [www.vishay.com/doc?99912](http://www.vishay.com/doc?99912)


**RoHS  
COMPLIANT**
**BENEFITS**

- Designed for increased operating efficiency in power conversion: UPS, SMPS, welding, induction heating
- Easy to assemble and parallel
- Direct mounting to heatsink
- Plug-in compatible with other SOT-227 packages
- Very low  $V_{CE(on)}$
- Low EMI, requires less snubbing

| ABSOLUTE MAXIMUM RATINGS         |                      |                                 |          |       |
|----------------------------------|----------------------|---------------------------------|----------|-------|
| PARAMETER                        | SYMBOL               | TEST CONDITIONS                 | MAX.     | UNITS |
| Collector to emitter voltage     | $V_{CES}$            |                                 | 1200     | V     |
| Continuous collector current     | $I_C$ <sup>(1)</sup> | $T_C = 25$ °C                   | 288      | A     |
|                                  |                      | $T_C = 90$ °C                   | 175      |       |
| Pulsed collector current         | $I_{CM}$             |                                 | 450      |       |
| Clamped inductive load current   | $I_{LM}$             |                                 | 450      |       |
| Diode continuous forward current | $I_F$                | $T_C = 25$ °C                   | 54       |       |
|                                  |                      | $T_C = 90$ °C                   | 32       |       |
| Gate to emitter voltage          | $V_{GE}$             |                                 | $\pm 20$ | V     |
| Power dissipation, IGBT          | $P_D$                | $T_C = 25$ °C                   | 1087     | W     |
|                                  |                      | $T_C = 90$ °C                   | 522      |       |
| Power dissipation, diode         | $P_D$                | $T_C = 25$ °C                   | 219      |       |
|                                  |                      | $T_C = 90$ °C                   | 105      |       |
| Isolation voltage                | $V_{ISOL}$           | Any terminal to case, t = 1 min | 2500     | V     |

**Note**

<sup>(1)</sup> Maximum collector current admitted is 100 A, to do not exceed the maximum temperature of terminals



| <b>ELECTRICAL SPECIFICATIONS</b> ( $T_J = 25\text{ }^\circ\text{C}$ unless otherwise specified) |                                |  |      |       |           |       |                      |
|---|--------------------------------|--|------|-------|-----------|-------|----------------------|
| PARAMETER   | SYMBOL                         | TEST CONDITIONS  | MIN. | TYP.  | MAX.      | UNITS |                      |
| Collector to emitter breakdown voltage  | $V_{BR(CES)}$                  | $V_{GE} = 0\text{ V}, I_C = 250\text{ }\mu\text{A}$  | 1200 | -     | -         | V     |                      |
| Collector to emitter voltage  | $V_{CE(on)}$                   | $V_{GE} = 15\text{ V}, I_C = 100\text{ A}$   | -    | 1.73  | 2.1       |       |                      |
|   |                                | $V_{GE} = 15\text{ V}, I_C = 100\text{ A}, T_J = 125\text{ }^\circ\text{C}$                        | -    | 1.98  | 2.2       |       |                      |
|   |                                | $V_{GE} = 15\text{ V}, I_C = 100\text{ A}, T_J = 150\text{ }^\circ\text{C}$                        | -    | 2.05  | -         |       |                      |
| Gate threshold voltage  | $V_{GE(th)}$                   | $V_{CE} = V_{GE}, I_C = 250\text{ }\mu\text{A}$  | -    | 5     | -         |       |                      |
|   |                                | $V_{CE} = V_{GE}, I_C = 7.5\text{ mA}$   | 4.9  | 5.9   | 7.9       |       |                      |
|   |                                | $V_{CE} = V_{GE}, I_C = 250\text{ }\mu\text{A}, T_J = 125\text{ }^\circ\text{C}$                   | -    | 2.9   | -         |       |                      |
| Temperature coefficient of threshold voltage  | $\Delta V_{GE(th)}/\Delta T_J$ | $V_{CE} = V_{GE}, I_C = 1\text{ mA}$ ( $25\text{ }^\circ\text{C}$ to $125\text{ }^\circ\text{C}$ ) | -    | -17.6 | -         |       | mV/ $^\circ\text{C}$ |
| Collector to emitter leakage current  | $I_{CES}$                      | $V_{GE} = 0\text{ V}, V_{CE} = 1200\text{ V}$  | -    | 0.9   | 100       |       | $\mu\text{A}$        |
|   |                                | $V_{GE} = 0\text{ V}, V_{CE} = 1200\text{ V}, T_J = 125\text{ }^\circ\text{C}$                     | -    | 0.85  | 10        | mA    |                      |
|   |                                | $V_{GE} = 0\text{ V}, V_{CE} = 1200\text{ V}, T_J = 150\text{ }^\circ\text{C}$                     | -    | 4     | 20        |       |                      |
| Forward voltage drop, diode   | $V_{FM}$                       | $I_F = 40\text{ A}, V_{GE} = 0\text{ V}$   | -    | 3.12  | 3.44      | V     |                      |
|   |                                | $I_F = 40\text{ A}, V_{GE} = 0\text{ V}, T_J = 125\text{ }^\circ\text{C}$                          | -    | 3.15  | 3.47      |       |                      |
|   |                                | $I_F = 40\text{ A}, V_{GE} = 0\text{ V}, T_J = 150\text{ }^\circ\text{C}$                          | -    | 3.25  | -         |       |                      |
| Gate to emitter leakage current   | $I_{GES}$                      | $V_{GE} = \pm 20\text{ V}$   | -    | -     | $\pm 200$ | nA    |                      |

| <b>SWITCHING CHARACTERISTICS</b> ( $T_J = 25\text{ }^\circ\text{C}$ unless otherwise specified) |              |  |  |      |      |               |    |
|---|--------------|--|--|------|------|---------------|----|
| PARAMETER   | SYMBOL       | TEST CONDITIONS  | MIN.   | TYP. | MAX. | UNITS         |    |
| Total gate charge (turn-on)   | $Q_g$        | $I_C = 150\text{ A}$ ( $t_p < 400\text{ }\mu\text{s}, D < 2\%$ ),<br>$V_{CC} = 600\text{ V}, V_{GE} = 15\text{ V}$   | -  | 830  | -    | nC            |    |
| Gate to emitter charge (turn-on)  | $Q_{ge}$     |  | -  | 180  | -    |               |    |
| Gate to collector charge (turn-on)  | $Q_{gc}$     |  | -  | 380  | -    |               |    |
| Turn-on switching loss  | $E_{on}$     | $I_C = 100\text{ A}, V_{CC} = 720\text{ V},$<br>$V_{GE} = 15\text{ V}, R_g = 2.2\text{ }\Omega,$<br>$L = 500\text{ }\mu\text{H}, T_J = 25\text{ }^\circ\text{C}$                                       | -  | 4.8  | -    | mJ            |    |
| Turn-off switching loss   | $E_{off}$    |  | -  | 7.0  | -    |               |    |
| Total switching loss  | $E_{tot}$    |  | -  | 11.8 | -    |               |    |
| Turn-on delay time  | $t_{d(on)}$  |  | Energy losses include tail and diode recovery<br>Diode used HFA16PB120 | -    | 274  | -             | ns |
| Rise time   | $t_r$        |  |  | -    | 67   | -             |    |
| Turn-off delay time   | $t_{d(off)}$ |  |  | -    | 271  | -             |    |
| Fall time   | $t_f$        |  |  | -    | 177  | -             | mJ |
| Turn-on switching loss  | $E_{on}$     |  |  | -    | 6.0  | -             |    |
| Turn-off switching loss   | $E_{off}$    |  |  | -    | 10.4 | -             |    |
| Total switching loss  | $E_{tot}$    | $I_C = 100\text{ A}, V_{CC} = 720\text{ V},$<br>$V_{GE} = 15\text{ V}, R_g = 2.2\text{ }\Omega,$<br>$L = 500\text{ }\mu\text{H}, T_J = 125\text{ }^\circ\text{C}$                                      |  | -    | 16.4 | -             | ns |
| Turn-on delay time  | $t_{d(on)}$  |  |  | -    | 285  | -             |    |
| Rise time   | $t_r$        |  |  | -    | 75   | -             |    |
| Turn-off delay time   | $t_{d(off)}$ |  | -  | 306  | -    |               |    |
| Fall time   | $t_f$        |  | -  | 244  | -    |               |    |
| Reverse bias safe operating area  | RBSOA        | $T_J = 150\text{ }^\circ\text{C}, I_C = 450\text{ A}, R_g = 4.7\text{ }\Omega,$<br>$V_{GE} = 15\text{ V}$ to $0\text{ V}, V_{CC} = 600\text{ V},$<br>$V_P = 1200\text{ V}, L = 500\text{ }\mu\text{H}$ | Fullsquare   |      |      |               |    |
| Diode reverse recovery time   | $t_{rr}$     | $I_F = 50\text{ A}, dI_F/dt = 200\text{ A}/\mu\text{s}, V_R = 400\text{ V}$  | -  | 164  | -    | ns            |    |
| Diode peak reverse current  | $I_{rr}$     |  | -  | 12   | -    | A             |    |
| Diode recovery charge   | $Q_{rr}$     |  | -  | 994  | -    | nC            |    |
| Diode reverse recovery time   | $t_{rr}$     | $I_F = 50\text{ A}, dI_F/dt = 200\text{ A}/\mu\text{s},$<br>$V_R = 400\text{ V}, T_J = 125\text{ }^\circ\text{C}$  | -  | 230  | -    | ns            |    |
| Diode peak reverse current  | $I_{rr}$     |  | -  | 16.5 | -    | A             |    |
| Diode recovery charge   | $Q_{rr}$     |  | -  | 1864 | -    | nC            |    |
| Short circuit safe operating area   | SCSOA        | $T_J = 150\text{ }^\circ\text{C}, R_g = 22\text{ }\Omega,$<br>$V_{GE} = 15\text{ V}$ to $0\text{ V}, V_{CC} = 900\text{ V},$<br>$V_P = 1200\text{ V}$  | 10   |      |      | $\mu\text{s}$ |    |



| THERMAL AND MECHANICAL SPECIFICATIONS  |                |                       |      |      |            |             |
|--|----------------|-----------------------|------|------|------------|-------------|
| PARAMETER                              | SYMBOL         | TEST CONDITIONS       | MIN. | TYP. | MAX.       | UNITS       |
| Junction and storage temperature range | $T_J, T_{Stg}$ |                       | -40  | -    | 150        | °C          |
| Junction to case                       | IGBT           |                       | -    | -    | 0.115      | °C/W        |
|  | Diode          |                       | -    | -    | 0.57       |             |
| Case to heatsink                       | $R_{thCS}$     | Flat, greased surface | -    | 0.05 | -          |             |
| Weight                                 |                |                       | -    | 30   | -          | g           |
| Mounting torque                        |                | Torque to terminal    | -    | -    | 1.1 (9.7)  | Nm (lbf.in) |
|  |                | Torque to heatsink    | -    | -    | 1.3 (11.5) | Nm (lbf.in) |
| Case style                             | SOT-227        |                       |      |      |            |             |

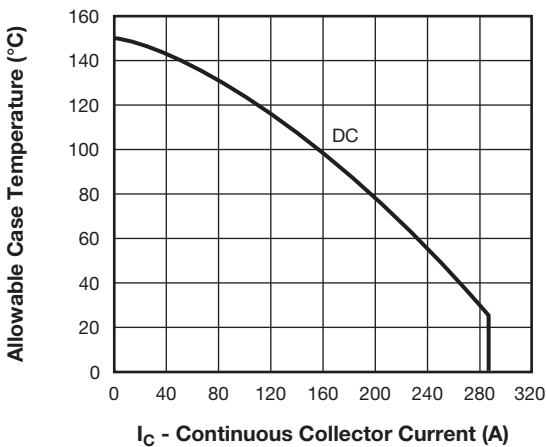


Fig. 1 - Maximum DC IGBT Collector Current vs. Case Temperature

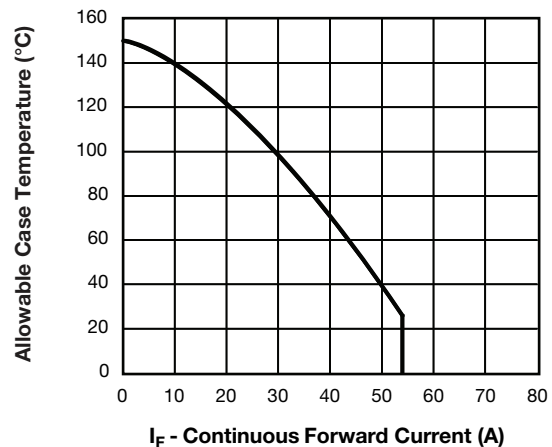


Fig. 3 - Maximum Allowable Forward Current vs. Case Temperature Diode Leg

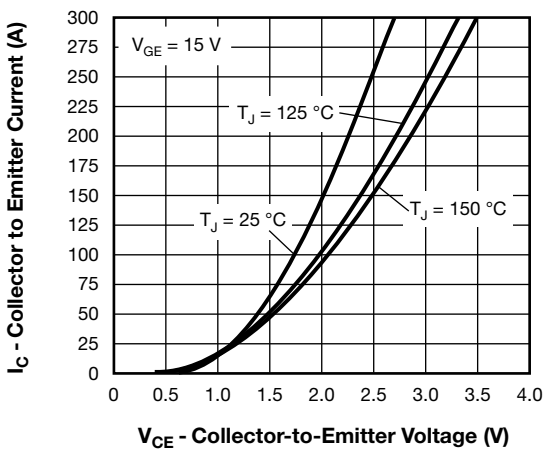


Fig. 2 - Typical Collector to Emitter Current Output Characteristics of IGBT

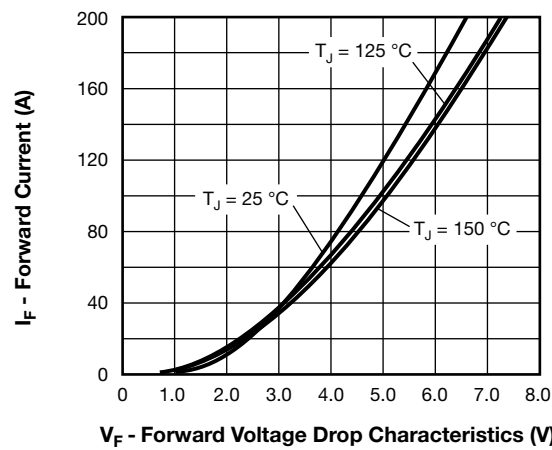


Fig. 4 - Typical Diode Forward Voltage Drop Characteristics

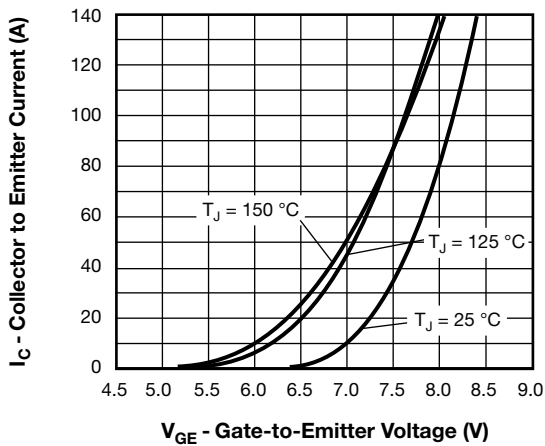


Fig. 5 - Typical IGBT Transfer Characteristics

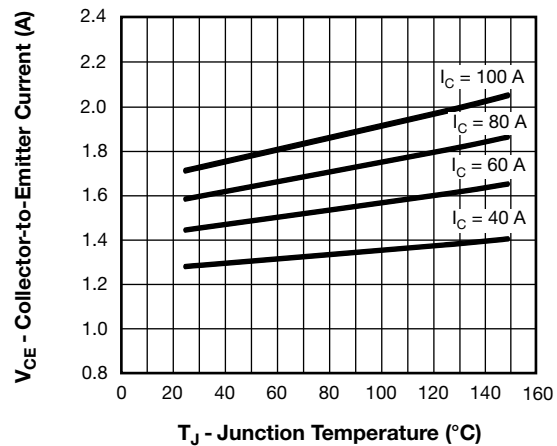


Fig. 8 - Typical IGBT Collector to Emitter Voltage vs. Junction Temperature,  $V_{GE} = 15\text{ V}$

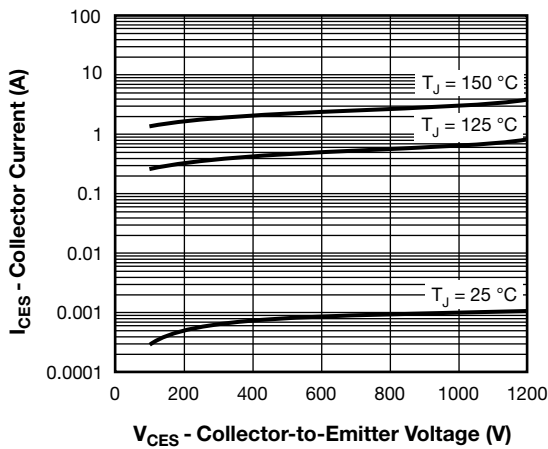


Fig. 6 - Typical IGBT Zero Gate Voltage Collector Current

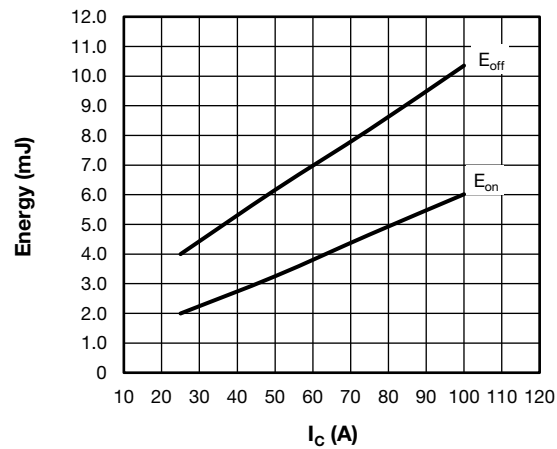


Fig. 9 - Typical IGBT Energy Losses vs.  $I_C$   
 $T_J = 125\text{ °C}$ ,  $L = 500\text{ }\mu\text{H}$ ,  $V_{CC} = 720\text{ V}$ ,  $R_g = 2.2\text{ }\Omega$ ,  $V_{GE} = 15\text{ V}$   
 Diode used: HFA16PB120

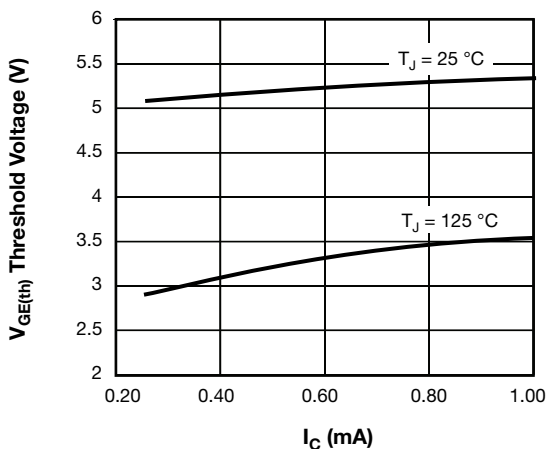


Fig. 7 - Typical IGBT Threshold Voltage

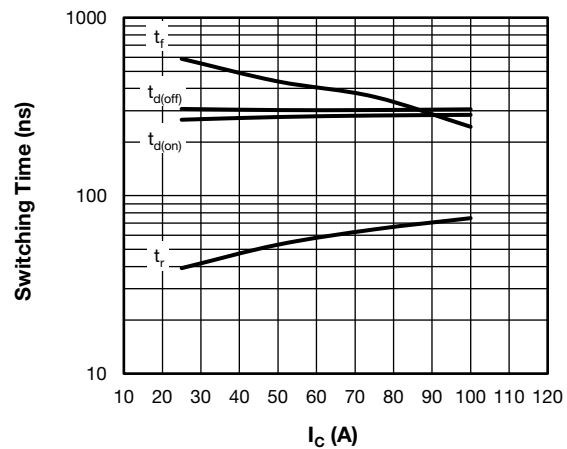


Fig. 10 - Typical IGBT Switching Time vs.  $I_C$   
 $T_J = 125\text{ °C}$ ,  $L = 500\text{ }\mu\text{H}$ ,  $V_{CC} = 720\text{ V}$ ,  $R_g = 2.2\text{ }\Omega$ ,  $V_{GE} = 15\text{ V}$   
 Diode used: HFA16PB120

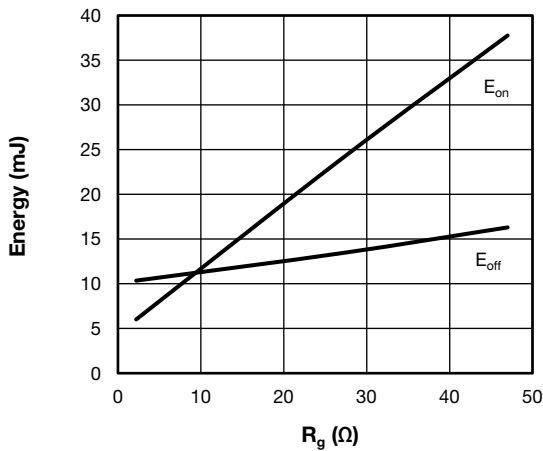


Fig. 11 - Typical IGBT Energy Losses vs.  $R_g$   
 $T_J = 125\text{ }^\circ\text{C}$ ,  $I_C = 100\text{ A}$ ,  $L = 500\text{ }\mu\text{H}$ ,  $V_{CC} = 720\text{ V}$ ,  $V_{GE} = 15\text{ V}$   
 Diode used: HFA16PB120

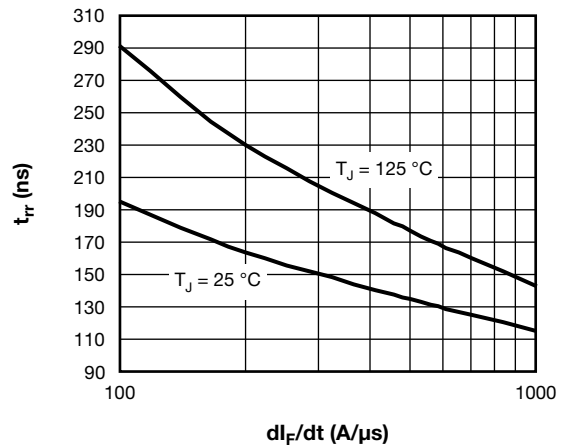


Fig. 13 - Typical Reverse Recovery Time vs.  $dI_F/dt$ , of Diode,  
 at  $I_F = 50\text{ A}$ ,  $V_R = 400\text{ V}$

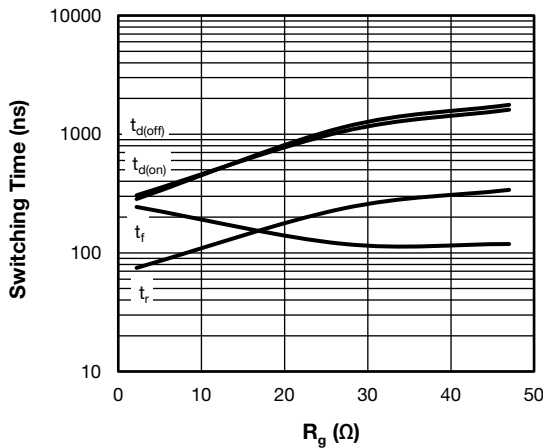


Fig. 12 - Typical IGBT Switching Time vs.  $R_g$   
 $T_J = 125\text{ }^\circ\text{C}$ ,  $L = 500\text{ }\mu\text{H}$ ,  $V_{CC} = 720\text{ V}$ ,  $I_C = 100\text{ A}$ ,  $V_{GE} = 15\text{ V}$   
 Diode used: HFA16PB120

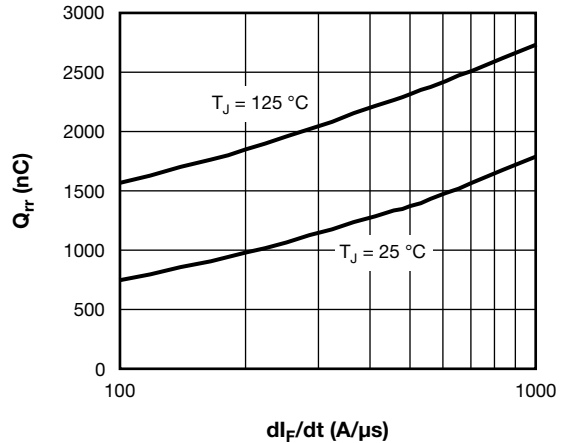


Fig. 14 - Typical Stored Charge vs.  $dI_F/dt$  of Diode,  
 at  $I_F = 50\text{ A}$ ,  $V_R = 400\text{ V}$

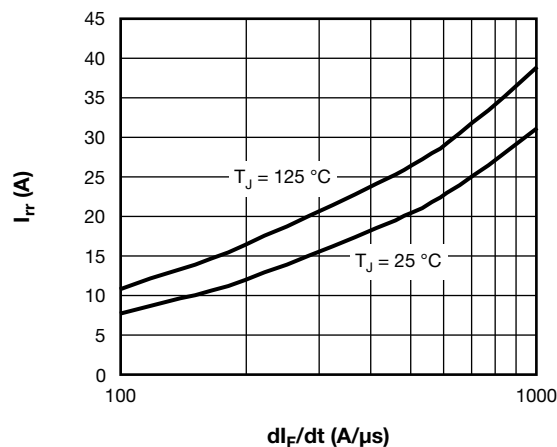


Fig. 15 - Typical Reverse Recovery Current vs.  $dI_F/dt$ , of Diode,  
 at  $I_F = 50\text{ A}$ ,  $V_R = 400\text{ V}$

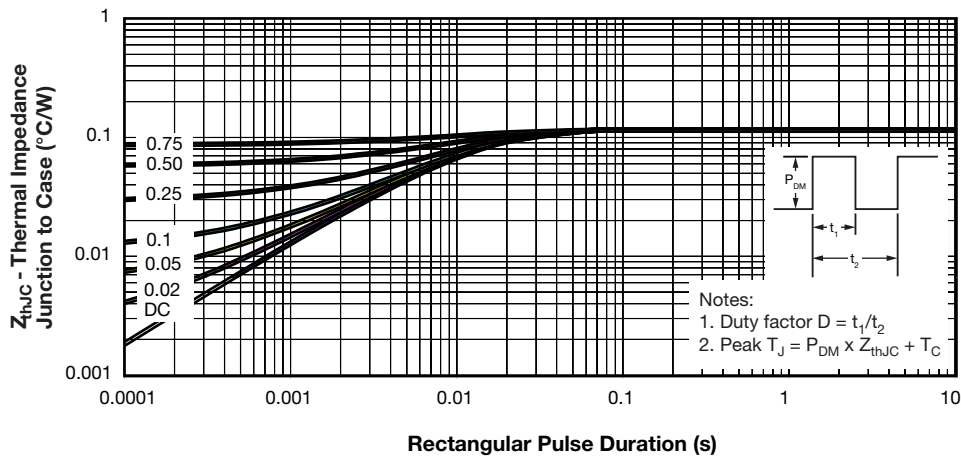


Fig. 16 - Maximum Thermal Impedance  $Z_{thJC}$  Characteristics (IGBT)

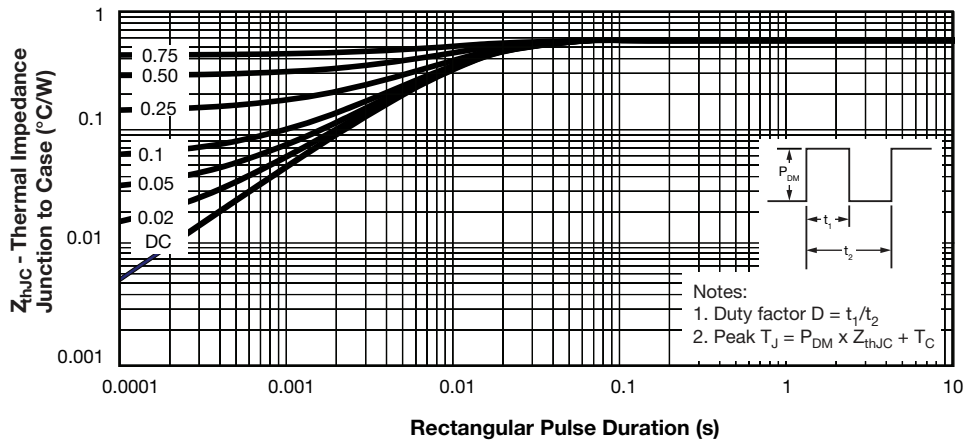


Fig. 17 - Maximum Thermal Impedance  $Z_{thJC}$  Characteristics (Diode)

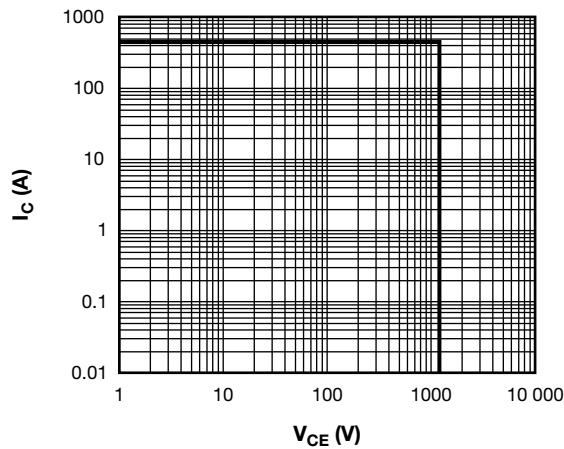
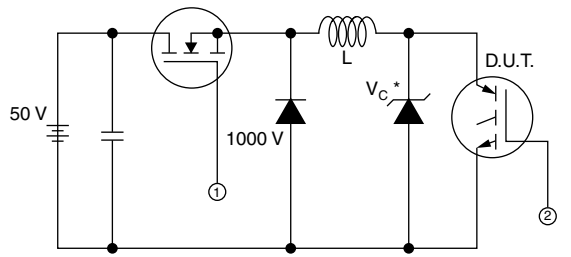


Fig. 18 - IGBT Reverse Bias SOA,  $T_J = 150\text{ }^\circ\text{C}$ ,  $V_{GE} = 15\text{ V}$



\* Driver same type as D.U.T.;  $V_C = 80\%$  of  $V_{ce(max)}$   
 \* Note: Due to the 50 V power supply, pulse width and inductor will increase to obtain  $I_d$

Fig. 19 - Clamped Inductive Load Test Circuit

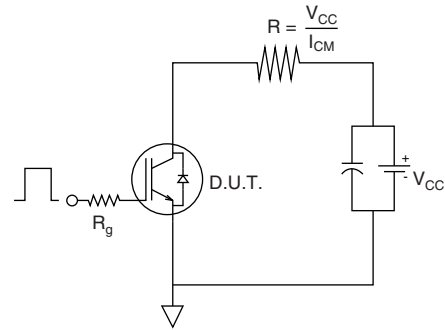


Fig. 19b - Pulsed Collector Current Test Circuit

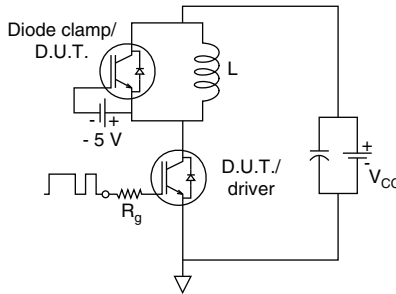


Fig. 20a - Switching Loss Test Circuit

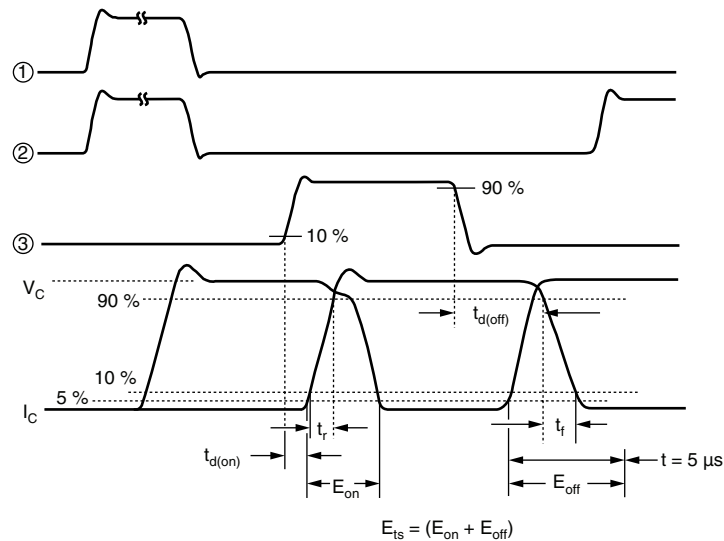
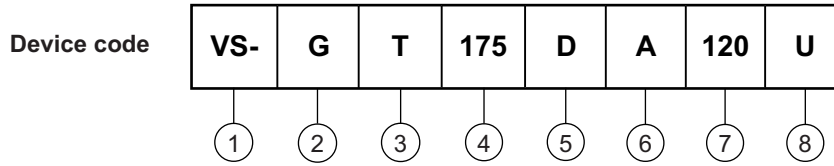


Fig. 20b - Switching Loss Waveforms Test Circuit



### ORDERING INFORMATION TABLE



- 1** - Vishay Semiconductors product
- 2** - Insulated Gate Bipolar Transistor (IGBT)
- 3** - Trench IGBT technology
- 4** - Current rating (175 = 175 A)
- 5** - Circuit configuration (D = Single switch with antiparallel diode)
- 6** - Package indicator (A = SOT-227)
- 7** - Voltage rating (120 = 1200 V)
- 8** - Speed/type (U = Ultrafast)

| CIRCUIT CONFIGURATION |                            |                 |
|-----------------------|----------------------------|-----------------|
| CIRCUIT               | CIRCUIT CONFIGURATION CODE | CIRCUIT DRAWING |
| Single switch diode   | D                          | <br>            |

| LINKS TO RELATED DOCUMENTS |  |
|----------------------------|--|
| Dimensions                 | <a href="http://www.vishay.com/doc?95423">www.vishay.com/doc?95423</a> |
| Packaging information      | <a href="http://www.vishay.com/doc?95425">www.vishay.com/doc?95425</a> |





### SOT-227 Generation II

**DIMENSIONS** in millimeters (inches)



**Note**

- Controlling dimension: millimeter



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